## Applicant(s)/Patent Under Application/Control No. Reexamination 10/661,439 SHIN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1763 Rudy Zervigon **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY US-6,783,627 B1 08-2004 Mahawili, Imad 156/345.38 Α 06-2003 Matsuse, Kimihiro US-6,576,062 B2 118/719 В US-5,010,842 A 04-1991 Oda et al. 118/723ME С D US-US-Ε US-F US-G USн US-US-US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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